## Accelerator Laboratory:

## Introduction to Beam Diagnostics and Instrumentation

Gero Kube, Kay Wittenburg DESY / MDI
-Introduction

- Beam Position Monitor
- Transverse Emittance / Beam Profile


## Diagnostics and Instrumentation

- instrumentation
> catchword for all technologies needed to produce primary measurements of beam parameters
- diagnostics
> making use of these instruments in order to
- operate the accelerators
$\rightarrow$ orbit control
- improve the accelerator performance
$\rightarrow$ feedback, emittance preservation
- deduce additional beam parameters or performance indicators of the machine by further data processing
$\rightarrow$ chromaticity measurements, betatron matching, ... (examples for circular accelerator)
- detect equipment faults
H. Schmickler, Introduction to Beam Diagnostics, CAS 2005
- outline
$\Rightarrow$ emphasis on beam instrumentation


## Beam Instrumentation for...

- beam position
- orbit, lattice parameters, tune, chromaticity, feedback,...
- beam intensity

- dc \& bunch current, coasting beam, lifetime, efficiencies,...
- beam profile

> longitudinal and transverse distributions, emittances,...
- beam loss
> identify position of losses, prevent damage of components,...

- beam energy
- mainly required by users,...
- luminosity (collider)
> key parameter, collision optimization...
and even more: charge states, mass numbers, timing...



## Beam Monitors: Physical Processes

- influence of particle electromagnetic field
> non-propagating fields, i.e. electro-magnetic influence of moving charge on environment
$\rightarrow$ beam transformers, pick-ups, ...
$>$ propagating fields, i.e. emission of photons
$\rightarrow$ synchrotron radiation monitors, (OTR), $\ldots$
particle electromagnetic field

relativistic contracion characterized by Lorentz factor

$$
\gamma=E / m_{0} c^{2} \quad \begin{aligned}
& E: \text { total energy } \\
& m_{0} c^{2}: \text { rest massenergy }
\end{aligned}
$$

$$
\text { proton: } \quad m_{p} c^{2}=938.272 \mathrm{MeV}
$$

$$
\text { electron: } \quad m_{e} c^{2}=0.511 \mathrm{MeV}
$$

## Beam Monitors: Physical Processes

$>$ non-propagating field
transverse electrical field components


## Beam Monitors: Physical Processes

- Coulomb interaction of charged particle penetrating matter
$\rightarrow$ viewing screens, residual gas monitors, ...



$$
-\frac{d E}{d x}=4 \pi N_{A} r_{e}^{2} m_{e} c^{2} \frac{Z_{T}}{A_{T}} \rho \frac{Z_{p}^{2}}{\beta^{2}}\left[\ln \frac{2 m_{e} c^{2} \gamma^{2} \beta^{2}}{I}-\beta^{2}\right]
$$

Bethe Bloch Equation („low-energy approximation")

- constants:
$\mathrm{N}_{\mathrm{A}}$ : Avogadro number
$m_{e}, r_{\mathrm{e}}$ : electron rest mass, classical electron radius
c: speed of light
- target material properties:
$\rho$ : material density
$\mathrm{A}_{\mathrm{T}}, \mathrm{Z}_{\mathrm{T}}$ : atomic mass, nuclear charge
I : mean excitation energy
particle properties:
$\mathrm{Z}_{\mathrm{p}}$ : charge
$\beta$ : velocity, with $\quad \gamma^{2}=\frac{1}{1-\beta^{2}}$
Electrons: Bremsstrahlung



## Beam Monitors: Physical Processes

- nuclear or elementary particle physics interactions
$\rightarrow$ beam loss monitors, luminosity monitors...


## electrons

> simple (point) objects

- interaction cross sections into final states can be calculated precisely


## hadrons

$>$ constituent nature (collection of quarks and gluons)

- interaction cross sections not precisely calculable
- interaction of particles with photon beams
$\rightarrow$ laser wire scanners, Compton polarimeters, ...
electrons: Compton scattering
hadrons: laser photo neutralization ( $\mathrm{H}^{-}$beam)



## Beam Position Monitor (BPM)

## Beam Position Monitors

- short version of E-XFEL BPM specification

| specified charge | rang <br> あ 末 $\frac{1}{3}$ $\frac{1}{2}$ | $0.1$ | $\mathrm{nC}$ $\begin{aligned} & \text { ᄃ } \\ & \hline \mathbf{O} \\ & \hline \mathbf{O} \end{aligned}$ | $\stackrel{\varrho}{\stackrel{\circ}{2}}$ |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | mm | mm |  | $\mu \mathrm{m}$ | $\mu \mathrm{m}$ | mm | mm | \% | $\mu \mathrm{m}$ | $\mu \mathrm{m}$ |
| Standard BPM | 219 | 40.5 | $\begin{aligned} & \hline 200 / \\ & 100 \\ & \hline \end{aligned}$ | Button | 50 | 10 | $\pm 3.0$ | $\pm 10$ | 1 | 10 | 200 |
| Cold BPM | 102 | 78 | 170 | Button/ Reentrant | 50 | 10 | $\pm 3.0$ | $\pm 10$ | 1 | 10 | 300 |
| Cavity BPM Beam Transfer Line | 12 | 40.5 | 255 | Cavity | 10 | 1 | $\pm 1.0$ | $\pm 2$ | 1 | 1 | 200 |
| Cavity BPM Undulator | 117 | 10 | 100 | Cavity | 1 | 0.1 | $\pm 0.5$ | $\pm 2$ | 1 | 0.1 | 50 |
| IBFB | 4 | 40.5 | 255 | Cavity | 1 | 0.1 | $\pm 1.0$ | $\pm 2$ | 1 | 0.1 | 200 |

$\Rightarrow$ different BPM types to meet different requirements

## Comparison of BPM Types

 $=$| BPM Type | Application | Precaution | Advantage | Disadvantage |
| :---: | :---: | :---: | :---: | :---: |
| Shoe-Box | p-synchrotrons heavy-ion accelerators | long bunches $\mathrm{f}_{\mathrm{RF}}<10 \mathrm{MHz}$ | very linear no $x-y$ coupling sensitive | complex mechanics capacitive coupling between plates |
| Button | p-linacs <br> all e-accelerators | $\mathrm{f}_{\text {RF }}>10 \mathrm{MHz}$ | simple mechanics | non-linear <br> $\mathrm{x}-\mathrm{y}$ coupling <br> possible signal deformation |
| Stripline | colliders <br> p-linacs <br> all e-accelerators | best for $\beta \approx 1$ short bunches | directivity large signal | complex $50 \Omega$ matching complex mechanics |
| Cavity | e-linacs (e.g. FELs) | short bunches, special applic. | very sensitive | very complex high frequency |

P. Forck, "Lecture Notes on Beam Instrumentation and Diagnostics", JUAS 2011


## Beam Position Monitor

- most common: capacitive pickups
$>$ signal generation via beam electric field
$>$ popular design: button-type pickup
$\rightarrow$ simple, cheap, ...
$\rightarrow$ moderate resolution
- operation principle
> electric field induces image charge on pick-up

LHC button pickup
courtesy: R.Jones (CERN)
$\rightarrow$ pick-up mounted isolated inside vacuum chamber
$\rightarrow$ amount of induced charge depends on distance between beam and pick-up

- button pickup: high pass characteristics

P. Forck, "Lecture Notes on Beam

Instrumentation and Diagnostics", JUAS 2011

## BPM Signal Calculation

- Beam Instrumentation System Simulator (B.I.S.S.)
calculation from BPM signals in time- and frequency domain
$>$ study influence of various parameters



## BPM Signals

- observation (1): singnals are short with small modulation
$\rightarrow$ single bunch response $\rightarrow$ nsec or sub-nsec pulse signals
$>$ beam position information $\rightarrow$ amplitude modulated on large (common mode) beam intensity signal!

- BPM building blocks


## BPM Pickup

> RF device, EM field detection, center of charge
> symmetrically arranged electrodes or resonant structure

## Read-out Electronics

> analog signal conditioning
> signal sampling (ADC)
$>$ digital signal processing
> data acquisition and control system interface

courtesy: M. Gasior (CERN)

## BPM Signals

- observation (2): nonlinearities $\Rightarrow$ especially BPMs for circular e-accelerators
> synchrotron radiation emission
$\rightarrow$ pickups mounted out of orbit plane
$>$ vacuum chamber not rotational symmetric
$\rightarrow \varepsilon_{\text {hor }} \gg \varepsilon_{\text {vert }} \quad$ (SR emission in hor. plane)
$\rightarrow$ injection oscillations due to off-axis injection (allows intensity accumulation)

courtesy: A.Delfs (DESY)


PETRA-III BPM close to ID
$\Rightarrow$ correction of strong non-linearities in beam position required

## Position Reconstruction

- two common monitor geometries
difference in position reconstruction
linac-type storage ring-type


$$
\begin{aligned}
& x=K_{x} \frac{P_{1}-P_{3}}{P_{1}+P_{3}} \\
& y=K_{y} \frac{P_{2}-P_{4}}{P_{2}+P_{4}}
\end{aligned}
$$

$$
\Rightarrow \text { difference-over-sum or } \frac{\Delta}{\Sigma}
$$

- position information
$\downarrow$ requires knowledge of monitor constant $\mathrm{K}_{\mathrm{x}}, \mathrm{K}_{\mathrm{y}}$
$\rightarrow$ rule of thumb (circular duct)

$$
\begin{array}{ll}
K_{x, y}=\frac{R}{2} \frac{\alpha}{\sin \alpha} & \text { linac-type } \\
K_{x, y}=\frac{R}{\sqrt{2}} \frac{\alpha}{\sin \alpha} & \text { storage ring-type }
\end{array}
$$



$$
\mathrm{x}=\mathrm{K}_{\mathrm{x}} \frac{\left(\mathrm{P}_{1}+\mathrm{P}_{4}\right)-\left(\mathrm{P}_{2}+\mathrm{P}_{3}\right)}{\mathrm{P}_{1}+\mathrm{P}_{2}+\mathrm{P}_{3}+\mathrm{P}_{4}}
$$

$$
y=K_{y} \frac{\left(P_{1}+P_{2}\right)-\left(P_{3}+P_{4}\right)}{P_{1}+P_{2}+P_{3}+P_{4}}
$$



## OLYMPUS @ DORIS (DESY)

- two-photon exchange in lepton scattering
> compare $\mathrm{e}^{+} \mathrm{p}$ and e-p elastic scattering
R. Milner et al., „The OLYMPUS experiment", Nucl. Instrum. Methods A741 (2014) 1



## Monitor Constant Measurement



## Tasks: BPMs

- calculate BPM signals using B.I.S.S
get a first impression about BPM signal forms
$\rightarrow \quad$ chamber geometry influence
$\rightarrow$ non-linearities
$\rightarrow$ output impedance
- calculate monitor constants for OLYMPUS BPMs
> use rule-of-thumb formulae for both geometries
$\rightarrow \quad$ compare with simulation results
- measure OLYMPUS BPM monitor constants (both geometries)
- define electrical center of both BPM bodies (origin)
$\checkmark$ perform 1-dim. scan along one axis $\quad \rightarrow$ max. wire position: $\pm 15 \mathrm{~mm}(!!!)$
$\rightarrow$ measure signal amplitudes from each button
$\rightarrow \quad$ calculate $\Delta / \Sigma$ from measured signals
$\rightarrow \quad$ plot $\Delta / \Sigma$ versus wire position and compare with simulation results
- determine monitor constant from slope at origin
- (measure 2-dim. position map)


# Transverse Phase Space: Beam Size and Emittance 

## Accelerator Key Parameters

- light source: spectral brilliance
> measure for phase space density of photon flux

$$
B=\frac{\text { Number of photons }}{[\mathrm{sec}]\left[\mathrm{mm}^{2}\right]\left[\mathrm{mrad}^{2}\right][0.1 \% \text { bandwidth }]}
$$

$>$ user requirement: high brightness
$\rightarrow$ lot of monochromatic photons on sample
> connection to machine parameters

$$
B \propto \frac{\mathrm{~N}_{\gamma}}{\sigma_{x} \sigma_{x^{\prime}} \sigma_{z} \sigma_{z^{\prime}}} \propto \frac{\mathrm{I}}{\varepsilon_{x} \varepsilon_{z}}
$$

- requirements
$>$ design of small emittance machine $\rightarrow$ proper choice of magnet lattice
> preserve small emittance
$\rightarrow$ question of stability
$\rightarrow$ require active feedback systems / careful design considerations
- collider: luminosity
> measure for the collider performance

$$
\dot{N}=L \cdot \sigma
$$

relativistic invariant proportionality factor between cross section $\sigma$ (property of interaction) and number of interactions per second
$>$ user requirement: high luminosity $\rightarrow$ lot of interactions in reaction channel
> connection to machine parameters

$$
L \propto \frac{I_{1} \cdot I_{2}}{\varepsilon}
$$

for two identical beams with emittances $\varepsilon_{x}=\varepsilon_{z}=\varepsilon$
bunch of particles

> measure small emittance

## Transverse Emittance

- projection of phase space volume
> separate horizontal, vertical and longitudinal plane
- accelerator key parameter
> defines luminosity / brilliance
- linear forces
$>$ any particle moves on an ellipse in phase space ( $\mathrm{x}, \mathrm{x}$ ')
ellipse rotates in magnets and shears along drifts
$\rightarrow$ but area is preserved: emittance


$$
\varepsilon=\gamma x^{2}+2 \alpha x x^{\prime}+\beta x^{\prime 2}
$$

( $\alpha, \beta, \gamma, \varepsilon$ : Courant-Snyder or Twiss parameters )

- transformation along accelerator
$>$ knowledge of the magnet structure (beam optics) $\rightarrow$ transformation from initial (i) to final (f) location
$\rightarrow \quad$ single particle transformation

$$
\binom{x}{x^{\prime}}_{f}=\underbrace{\left(\begin{array}{ll}
R_{11} & R_{12} \\
R_{21} & R_{22}
\end{array}\right)}_{R} \cdot\binom{x}{x^{\prime}}_{i}
$$

$\rightarrow \quad$ transformation of optical functions

$$
\left(\begin{array}{c}
\beta \\
\alpha \\
\gamma
\end{array}\right)_{f}=\left(\begin{array}{ccc}
R_{11}{ }^{2} & -2 R_{11} R_{12} & R_{12}{ }^{2} \\
-R_{11} R_{21} & 1+R_{11} R_{21} & -R_{12} R_{22} \\
R_{21}{ }^{21} & -2 R_{21} R_{22} & R_{22}{ }^{2}
\end{array}\right) \cdot\left(\begin{array}{c}
\beta \\
\alpha \\
\gamma
\end{array}\right)_{i}
$$

## Transverse Emittance Ellipse

- propagation along accelerator
> change of ellipse shape and orientation
$\rightarrow$ area is preserved

$$
\varepsilon=\gamma(s) x(s)^{2}+2 \alpha(s) x(s) x^{\prime}(s)+\beta(s) x^{\prime}(s)^{2}
$$

$$
\begin{aligned}
& \alpha(s)=-\frac{\beta^{\prime}(s)}{2} \\
& \gamma(s)=\frac{1+\alpha^{2}(s)}{\beta(s)}
\end{aligned}
$$

$$
x(s)=\sqrt{\varepsilon \beta(s)} \cdot \cos \Psi(s)+\Phi_{-}^{-}
$$



## Emittance and Beam Matrix

 GEMEINSCHAFT

- beam matrix

$$
\begin{gathered}
\Sigma=\left(\begin{array}{ll}
\Sigma_{11} & \Sigma_{12} \\
\Sigma_{21} & \Sigma_{22}
\end{array}\right)=\left(\begin{array}{ll}
\left\langle x^{2}\right\rangle & \left\langle x x^{\prime}\right\rangle \\
\left\langle x x^{\prime}\right\rangle & \left\langle x^{\prime 2}\right\rangle
\end{array}\right)=\varepsilon\left(\begin{array}{cc}
\beta & -\alpha \\
-\alpha & \gamma
\end{array}\right) \\
\varepsilon=\sqrt{\operatorname{det} \Sigma}=\sqrt{\Sigma_{11} \cdot \Sigma_{22}-\Sigma_{12}^{2}}
\end{gathered}
$$

> transformation of beam matrix

$$
\Sigma^{1}=\mathrm{R} \Sigma^{0} \mathrm{R}^{T} \quad R=\left(\begin{array}{ll}
R_{11} & R_{12} \\
R_{21} & R_{22}
\end{array}\right)
$$

- via Twiss parameters

$$
\varepsilon=\gamma x^{2}+2 \alpha x x^{\prime}+\beta x^{\prime 2}
$$

- statistical definition
P.M. Lapostolle, IEEE Trans. Nucl. Sci. NS-18, No. 3 (1971) 1101

$$
\varepsilon_{r m s}=\sqrt{\left\langle x^{2}\right\rangle\left\langle x^{\prime 2}\right\rangle-\left\langle x x^{\prime}\right\rangle^{2}}
$$

$2^{\text {nd }}$ moment of beam distribution $\rho(x)$

$$
\left\langle x^{2}\right\rangle=\frac{\int_{-\infty}^{\infty} d x x^{2} \cdot \rho(x)}{\int_{-\infty}^{\infty} d x \rho(x)}
$$

$\Rightarrow \varepsilon_{\mathrm{rms}}$ is measure of spread in phase space
> root-mean-square (rms) of distribution

$$
\sigma_{x}=\left\langle x^{2}\right\rangle^{1 / 2}
$$

$>\varepsilon_{\mathrm{rms}}$ useful definition for non-linear beams
$\rightarrow$ usually restriction to certain range (c.f. $90 \%$ of particles instead of $[-\infty,+\infty]$ )

## Emittance Measurement: Principle

- emittance: projected area of transverse phase space volume
- not directly accessible for beam diagnostics

- measurement schemes
> beam matrix based measurements
$\rightarrow$ determination of beam matrix elements:
- measured quantity
$\Rightarrow$ beam size

$$
\sqrt{\Sigma_{11}}=\sqrt{\left\langle x^{2}\right\rangle}=\sqrt{\varepsilon \beta}
$$

$\Rightarrow$ beam divergence $\sqrt{\Sigma_{22}}=\sqrt{\left\langle x^{\prime 2}\right\rangle}=\sqrt{\varepsilon \gamma}$
divergence measurements seldom in use
$\rightarrow$ restriction to profile measurements
> mapping of phase space
$\rightarrow$ restrict to (infenitesimal) element in space coordinate, convert angles x‘ in position

## Circular Accelerators

- emittance diagnostics in circular accelerators
> circular accelerator: periodic with circumference L
$\rightarrow$ one-turn transport matrix: $\mathrm{R}(\mathrm{s}+\mathrm{L})=\mathrm{R}(\mathrm{s})$
$\rightarrow$ Twiss parameters $\alpha(\mathrm{s}), \beta(\mathrm{s}), \gamma(\mathrm{s})$ uniquely defined at each location in ring
> measurement at one location in ring sufficient to determine $\varepsilon$
$\rightarrow$ measured quantity: beam profile / angular distribution
- classification

$$
\begin{array}{lll}
\text { beam spot } & \text { wavefront } & \text { spatial resolving } \\
\text { detector (CCD) }
\end{array}
$$

$>$ imaging
$\rightarrow$ beam size
> interference
$\rightarrow$ beam size

image size

interference pattern
> projection
$\rightarrow$ beam divergence

angular distribution

## Beam Matrix based Measurements

- starting point: beam matrix

$$
\Sigma=\left(\begin{array}{ll}
\Sigma_{11} & \Sigma_{12} \\
\Sigma_{21} & \Sigma_{22}
\end{array}\right)=\left(\begin{array}{ll}
\left\langle x^{2}\right\rangle & \left\langle x x^{\prime}\right\rangle \\
\left\langle x x^{\prime}\right\rangle & \left\langle x^{\prime 2}\right\rangle
\end{array}\right)=\varepsilon\left(\begin{array}{cc}
\beta & -\alpha \\
-\alpha & \gamma
\end{array}\right)
$$

- emittance determination
$>$ measurement of $\mathbf{3}$ matrix elements $\boldsymbol{\Sigma}_{11}, \boldsymbol{\Sigma}_{12}, \boldsymbol{\Sigma}_{\mathbf{2 2}}$
$>$ remember: beam matrix $\Sigma$ depends on location, i.e. $\Sigma(\mathrm{s})$

$$
\varepsilon=\sqrt{\operatorname{det} \Sigma}=\sqrt{\Sigma_{11} \cdot \Sigma_{22}-\Sigma_{12}^{2}}
$$

$\rightarrow$ determination of matrix elements at same location required

- access to matrix elements
$>$ profile monitor determines only $\sigma=\sqrt{\Sigma_{11}}$
> other matrix elements can be inferred from beam profiles taken under various transport conditions
$\rightarrow$ knowledge of transport matrix R required

$$
\Sigma^{b}=R \cdot \Sigma^{a} \cdot R^{T} \quad R=\left(\begin{array}{ll}
R_{11} & R_{12} \\
R_{21} & R_{22}
\end{array}\right)
$$

- measurement of at least 3 profiles for 3 matrix elements

$$
\begin{aligned}
& \Sigma_{11}^{a} \\
& \Sigma_{11}^{b}=R_{11}^{2} \cdot \Sigma_{11}^{a}+2 R_{11} R_{12} \cdot \Sigma_{12}^{a}+R_{12}^{2} \cdot \Sigma_{22}^{a} \\
& \Sigma_{11}^{c}=\bar{R}_{11}^{2} \cdot \Sigma_{11}^{a}+2 \bar{R}_{11} \bar{R}_{12} \cdot \Sigma_{12}^{a}+\bar{R}_{12}^{2} \cdot \Sigma_{22}^{a}
\end{aligned}
$$

> measurement : profiles
$\sigma^{a, b, c}=\sqrt{\Sigma_{11}^{a, b, c}}$
> known: transport optics

$$
R, \bar{R}
$$

> deduced: matrix elements
$\Sigma_{11}^{a}, \Sigma_{12}^{a}, \Sigma_{22}^{a}$
$\rightarrow$ more than 3 profile measurements favourable, data subjected to least-square analysis

## Beam Matrix based Measurements

- "quadrupole scan" method
$>$ use of variable quadrupole strengths
$\rightarrow$ change quadrupole settings and measure beam size in profile monitor located downstream

quadrupole transfer matrix

$$
Q=\left(\begin{array}{cc}
1 & 0 \\
\pm 1 / f & 1
\end{array}\right)
$$

drift space transfer matrix

$$
\rightarrow \quad \mathbf{R}=\mathbf{S Q}
$$

$$
S=\left(\begin{array}{ll}
1 & l \\
0 & 1
\end{array}\right)
$$



## Beam Matrix based Measurements

- "multi profile monitor" method
> fixed particle beam optics
$\rightarrow$ measure beam sizes using multiple profile monitors at different locations
> example:
emittance measurement setup at FLASH injector (DESY)
courtesy: K. Honkavaara (DESY)
- task

> beam profile measurement


## Storage Ring: Profile Measurement

## - circular accelerator

$>$ only non- or minimum-invasive diagnostics $\rightarrow$ otherwise beam loss after few turns

- $e^{-} / e^{+}$ring
> working horse: synchrotron radiation
$\rightarrow$ problem: heat load @ extraction mirror


## - hadron ring

> wire scanners: scan of thin wire across the beam
$>$ detect beam-wire interaction as function of wire position



> residual gas monitor:
> residual gas ionization / luminescence

T. Giacomini et al., Proc. BIW 2004, p. 286

## Linac or Transport Line: Profiles

## - linear machine

$>$ single pass diagnostics $\rightarrow$ interaction with matter $\quad$ (care has to be taken)

- hadron accelerators
> working horse: screen monitors
$\rightarrow \quad$ scintillating light spot intensity corresponds to beam profile
> wire harp
$\rightarrow \quad$ extension of wire scanner


B. Walasek-Höhne et al., IEEE

Trans. Nucl. Sci. 59 (2012) 2307

$$
\sigma=1.44 \mu \mathrm{~m}
$$

G. Kube et al., Proc. IBIC 2015,

Melbourne (Australia), TUPB012

## Screen Monitors

- principle
> radiator
$\rightarrow$ scintillator / OTR screen
$\rightarrow$ generation of light spot: intensity distribution reflects
particle beam density (i.e. linear light generation mechanism)
> optical system / CCD
$\rightarrow$ imaging / recording of light spot
$>$ target mover
$\rightarrow$ move screen in / out of particle beam
> illumination
$\rightarrow$ check system performance

B. Walasek-Höhne et al., IEEE Trans. Nucl. Sci. 59 (2012) 2307

- screen monitor setup
$>$ radiator $\rightarrow \mathrm{Al}_{2} \mathrm{O}_{3}: \mathrm{Cr}$ (Chromox) screen
(thickness $1.0 \mathrm{~mm} / 0.5 \mathrm{~mm} / 0.3 \mathrm{~mm}$ )
> CCD $\rightarrow$ USB camera
$>$ optics $\rightarrow$ CCTV lens


## Size Measurement: Resolution

- fundamental resolution limit
$>$ point observer detecting photons from point emitter

$\Delta x$
$\Delta \mathrm{p}_{x}=2 \hbar \mathrm{k} \cdot \sin \vartheta \approx 2 \cdot \frac{h}{2 \pi} \cdot \frac{2 \pi}{\lambda} \cdot \sin \vartheta$
$\mathrm{NA}=\sin \vartheta:$
numerical aperture

$$
\Delta \mathrm{x} \cdot \Delta \mathrm{p}_{x} \approx h \quad \Rightarrow \quad \Delta \mathrm{x} \approx \frac{\lambda}{2 \sin \vartheta}
$$

$\square$ high resolution:
(i) small $\lambda$
(ii) high NA

- image of point source

- resolution broadening: additional contributions
> depth of field
$\rightarrow \quad$ mainly for synchrotron radiation based diagnostics
> radius of curvature


## Emittance Measurement Test Setup

- emittance of laser beam: "multi-profile monitor" method

- calibration / resolution targets
> check system performance of detector system



## Tasks: Emittance Diagnostics

- estimate the image resolution for an optical synchrotron radiation profile monitor
$>$ modern $3^{\text {rd }}$ generation light source:

$$
\mathrm{E}=6 \mathrm{GeV}, \lambda_{\text {obs }}=500 \mathrm{~nm}, \sigma_{\mathrm{y}}=10 \mu \mathrm{~m}
$$

$\rightarrow \quad$ assume „self diffaction", i.e. aperture limitation imposed by radiation angular distribution $(1 / \gamma)$

- derive the single particle transport matrix for a drift space
> assume paraxial approximation

$$
\rightarrow \quad \sin \left(x^{\prime}\right) \approx x^{\prime}
$$

- calculate the evolution of the beam size after a drift space
$\downarrow$ use the beam matrix transformation together with the transport matrix R for a drift space
- investigate the performance of the CCD
$>$ spatial calibration $\rightarrow$ dot grid target ( 0.5 mm spacing)
$\rightarrow$ resolution $\rightarrow$ Siemens star, USAF 1951 target
- measure the emittance of the laser beam
$>$ measure spot sizes for different distances of the lens
> analyse the horizontal profiles as function of the lens position
$\triangleright$ calculate the laser beam emittance $\quad \rightarrow \quad$ use the simplest way with only 2 values
> (repeat with a different scintillator thickness)

